

## SHEN ZHEN ROCKETEK ELECTRONICS CO., LTD

# CE EMC REPORT

Prepared For:	SHEN ZHEN ROCKETEK ELECTRONICS CO., LTD
	3F Block D, Peng Li Tai Industry Park, Long Gang District, Shenzhen, China.
Product Name:	USB CARD READER
Trade Name:	ROCKETEK
Model :	RT-SCR1, RT-SCR,RT-SCR1,RT-SCR1A,RT-SCR2,RT-SCR3, RT-USCR3, RT-CSCR3, RT-SCR4, RT-SCR10, RT-CR301, RT-CR310, RT-CR317, RT-CR318, RT-CR319, RT-SCR812, RT-SCR816, RT-CSCR1,RT-CSCR2,RT-SCR01,RT-SCR02,RT-SCR611,RT-SCR04 RT-SCR7,RT-SCR8,RT-SCR9,RT-SCR11,RT-SCR12,RT-SV
Prepared By:	BST Testing (Shenzhen) Co.,Ltd. No.7, New Era Industrial Zone, Guantian, Bao'an District, Shenzhen, Guangdong, China
Test Date:	Jan.13-20.2021
Date of Report:	Jan.20,2021
Report No.:	BSTXD210115976601ER



#### TEST REPORT DECLARATION

Applicant	:	SHEN ZHEN ROCKETEK ELECTRONICS CO., LTD
Address	:	3F Block D, Peng Li Tai Industry Park, Long Gang District, Shenzhen,
		China.
EUT Description	:	CSD CARD READER
Model Number	:	RT-SCR1
		(Note: The series products have the same circuit diagram, PCB
		layout and functionality. The differences are the model name and
		appearance, so, we select RT-SCR1 to test.)

#### Test Standards:

EN 55032:2015

EN 61000-3-2:2014

EN 61000-3-3:2013

EN 55035:2017

The EUT described above is tested by BST Testing (Shenzhen) Co.,Ltd. EMC Laboratory to determine the maximum emissions from the EUT and ensure the EUT to be compliance with the immunity requirements of the EUT. BST Testing (Shenzhen) Co.,Ltd. EMC Laboratory is assumed full responsibility for the accuracy of the test results. Also, this report shows that the EUT technically complies with the 2014/30/EU directive and its amendment requirements.

The test report is valid for above tested sample only and shall not be reproduced in part without written approval of the laboratory.

Prepared by:	Ivy shong
	Assistant
Tested by:	Toby zhong
Reviewer:	APPROVED CONTRACTOR OF THE PROVED CONTRACTOR O
Approved & Authorized Signer:	Superior
	Salon/Manager



## 1. TEST RESULTS SUMMARY

Table 1 Test Results Summary

Test Items	Test Results
Radiated Emission	PASS
Conducted Disturbance	PASS
Harmonic Current	PASS
Voltage Fluctuation and Flicker	PASS
Electrostatic Discharge Immunity	PASS
Radiated Electromagnetic Fields Immunity	PASS
Electric Fast Transient Burst Immunity	PASS
Surge Immunity	PASS
Injected currents susceptibility test	PASS
Magnetic Field Immunity Test	PASS
Voltage dips and interruptions Immunity	PASS

#### 2. GENERAL INFORMATION

#### 2.1.Report information

- 2.1.1.This report is not a certificate of quality; it only applies to the sample of the specific product/equipment given at the time of its testing. The results are not used to indicate or imply that they are application to the similar items. In addition, such results must not be used to indicate or imply that BST approves recommends or endorses the manufacture, supplier or use of such product/equipment, or that BST in any way guarantees the later performance of the product/equipment.
- 2.1.2. The sample/s mentioned in this report is/are supplied by Applicant, BST therefore assumes no responsibility for the accuracy of information on the brand name, model number, origin of manufacture or any information supplied.
- 2.1.3.Additional copies of the report are available to the Applicant at an additional fee. No third part can obtain a copy of this report through BST, unless the applicant has authorized BST in writing to do so.

#### 2.2. Measurement Uncertainty

(95% confidence levels, k=2)

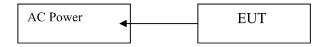
Test Item	Uncertainty
Uncertainty for Conduction emission test	2.2dB
Uncertainty for Radiation emission test	4.0dB
(30MHz to 1GHz)	4.0dB

## 3. PRODUCT DESCRIPTION

## 3.1.EUT Description

Description	:	USB CARD READER
Applicant	:	SHEN ZHEN ROCKETEK ELECTRONICS CO., LTD 3F Block D, Peng Li Tai Industry Park, Long Gang District, Shenzhen, China.
Manufacturer	:	SHEN ZHEN ROCKETEK ELECTRONICS CO., LTD 3F Block D, Peng Li Tai Industry Park, Long Gang District, Shenzhen, China.
Model Number	:	RT-SCR1, RT-SCR,RT-SCR1,RT-SCR1A,RT-SCR2,RT-SCR3, RT-USCR3, RT-CSCR3, RT-SCR4, RT-SCR10, RT-CR301, RT-CR310, RT-CR317, RT-CR318, RT-CR319, RT-SCR812, RT-SCR816, RT-SCR04 RT-CSCR1,RT-CSCR2,RT-SCR01,RT-SCR02,RT-SCR611,RT-SCR7, RT-SCR8,RT-SCR9,RT-SCR11,RT-SCR12,RT-Sv

## 3.2.Block Diagram of EUT Configuration



## 3.3. Operating Condition of EUT

Test mode 1: ON

## 3.4. Test Conditions

Temperature: 23-26 ℃ Relative Humidity: 55-68 %

#### 3.5. Modifications

No modification was made.



#### 3.6. Abbreviations

AC Alternating Current AMN Artificial Mains Network

DC Direct Current EM ElectroMagnetic

EMC ElectroMagnetic Compatibility

EUT Equipment Under Test
IF Intermediate Frequency

RF Radio Frequency rms root mean square

EMS Electromagnetic Interference
EMS Electromagnetic Susceptibility

#### 3.7.Performance Criterion

**Criterion A:** The equipment shall continue to operate as intended without operator intervention. No degradation of performance of loss of function is allowed below a performance level specified by the manufacturer when the equipment is used as intended.

**Criterion B:** After the test, the equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the equipment is used as intended.

**Criterion C:** Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions.



## 4. TEST EQUIPMENT USED

## 4.1.For Conducted Emission Test

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	Test Receiver	Rohde & Schwarz	ESHS30	828985/018	Oct. 08, 20	1 Year
2.	Pulse Limiter	Rohde & Schwarz	ESH3-Z2	100006	Oct. 08, 20	1 Year
3.	L.I.S.N.	Rohde & Schwarz	ESH2-Z5	834549/005	Oct. 08, 20	1 Year
4.	Conical	Emtek	N/A	N/A	N/A	N/A
5.	Voltage Probe	Schwarzbeck	TK9416	N/A	Oct. 08, 20	1 Year
6.	Coaxial Switch	Anritsu	MP59B	6100214550	Oct. 08, 20	1 Year

#### 4.2. For Radiated Emission Measurement

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	Spectrum Analyzer	ANRITSU	MS2661C	6200140915	Oct. 08, 20	1 Year
2.	Test Receiver	Rohde&Schwarz	ESC830	828982/018	Oct. 08, 20	1 Year
3.	Bilog Antenna	Schwarzbeck	VULB9163	142	Oct. 08, 20	1 Year
4.	50 Coaxial Switch	Anritsu Corp	MP59B	6100237248	Oct. 08, 20	1 Year
5.	Cable	Schwarzbeck	AK9513	ACRX1	Oct. 08, 20	1 Year
6.	Cable	Rosenberger	N/A	FR2RX2	Oct. 08, 20	1 Year
7.	Cable	Schwarzbeck	AK9513	CRRX2	Oct. 08, 20	1 Year
8.	Cable	Schwarzbeck	AK9513	CRRX2	Oct. 08, 20	1 Year
9.	Signal Generator	HP	864A	3625U00573	Oct. 08, 20	1 Year

#### 4.3. For Harmonic / Flicker Test

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	Harmonic and Flicker	Laplace	AC2000A	309709	Oct. 08, 20	1 Year
	analyzer					

## 4.4. For Electrostatic Discharge Immunity Test

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	ESD Tester	HAEFELY	PSD 1600	Н911'292	Oct. 08, 20	1 Year

## 4.5.For RF Strength Susceptibility Test

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	Signal Generator	HP	8648A	3633A02081	Oct. 08, 20	1 Year
2.	Amplifier	A&R	500A100	17034	NCR	NCR
3.	Amplifier	A&R	100W/1000M1	17028	NCR	NCR
4.	Isotropic Field Monitor	A&R	FM2000	16829	NCR	NCR
5.	Isotropic Field Probe	A&R	FLW220100	16755	Oct. 08, 20	1 Year
6.	Biconic Antenna	EMCO	3108	9507-2534	NCR	NCR
7.	Log-periodic Antenna	A&R	AT1080	16812	NCR	NCR
8.	PC	N/A	486DX2	N/A	N/A	N/A



## 4.6.For Electrical Fast Transient/Burst Immunity Test

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	Burst Tester	HAEFELY	PEFT 4010	080981-16	Oct. 08, 20	1 Year

## 4.7.For Surge Test

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	Surge Tester	HAEFELY	PSURGE4.1	080107-04	Oct. 08, 20	1 Year

## 4.8. For Injected Currents Susceptibility Test

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	Simulator	EMTEST	CWS 500C	0900-12	Oct. 08, 20	1 Year
2.	CDN	EMTEST	CDN-M2	510010010010	Oct. 08, 20	1 Year
3.	VDN	EMTEST	CDN-M3	0900-11	Oct. 08, 20	1 Year
4.	Injection Clamp	EMTEST	F-2031-23MM	368	Oct. 08, 20	1 Year
5.	Attenuator	EMTEST	ATT6	0010222a	Oct. 08, 20	1 Year

## 4.9.For Magnetic Field Immunity Test

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	Magnetic Field Tester	HEAFELY	MAG100.1	083858-10	Oct. 08, 20	1 Year

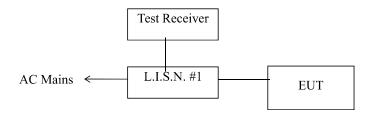
## 4.10.For Voltage Dips and Interruptions Test

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	Dips Tester	HEAFELY	PLINE 1610	083732-18	Oct. 08, 20	1 Year



#### 5. POWER LINE CONDUCTED EMISSION TEST

#### 5.1.Block Diagram of Test Setup



#### 5.2. Test Standard

EN 55032:2015

#### 5.3. Power Line Conducted Emission Limit

Frequency	Limits dB(μV)		
MHz	Quasi-peak Level	Average Level	
0.15 ~ 0.50	66 ~ 56*	56 ~ 46*	
0.50 ~ 5.00	56	46	
5.00 ~ 30.00	60	50	

Notes: 1. \*Decreasing linearly with logarithm of frequency.

2. The lower limit shall apply at the transition frequencies.

#### 5.4.EUT Configuration on Test

The following equipments are installed on conducted emission test to meet EN55032 requirement and operating in a manner, which tends to maximize its emission characteristics in a normal application.

#### 5.4.1.EUT Information

Model Number : RT-SCR1 Serial Number : N/A

Manufacturer : SHEN ZHEN ROCKETEK ELECTRONICS CO., LTD

### 5.5.Operating Condition of EUT

- 5.5.1. Setup the EUT and simulators as shown in Section 5.1.
- 5.5.2. Turn on the power of all equipments.
- 5.5.3.Let the EUT work in test modes (ON) and test it.

#### 5.6. Test Procedure

The EUT is put on the ground and connected to the AC mains through a Artificial Mains Network (AMN). This provided 50ohm-coupling impedance for the tested equipments. Both sides of AC line are checked to find out the maximum conducted emission levels according to the EN55032 regulations during conducted emission test.

The bandwidth of the test receiver is set at 9kHz.

The frequency range from 150 KHz to 30 MHz is investigated.

#### 5.7.Test Result

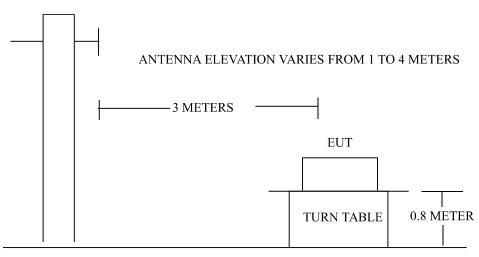
**PASS** 



#### 6. RADIATED EMISSION TEST

## 6.1.Setup Diagram

ANTENNA TOWER



**GROUND PLANE** 

#### 6.2.Test Standard

EN 55032:2015

#### 6.3. Radiated Emission Limit

All emanations from a Class B computing devices or system, including any network of conductors and apparatus connected thereto, shall not exceed the level of field strengths specified below:

FREQUENCY	DISTANCE	FIELD STRENGTHS LIMITS
(MHz)	(Meters)	(dBµV/m)
30 ~ 230	3	40
230 ~ 1000	3	47

Note:(1) The tighter limit shall apply at the edge between two frequency bands.

(2) Distance refers to the distance in meters between the measuring instruments antenna and the closed point of any part of the EUT.

#### 6.4.EUT Configuration on Test

The EN55032 Class B regulations test method must be used to find the maximum emission during radiated emission test.



## 6.5. Operating Condition of EUT

- 6.5.1. Setup the EUT as shown on Section 6.1.
- 6.5.2. Turn on the power of all equipments.
- 6.5.3.Let the EUT work in test mode (on) and measure it.

#### 6.6. Test Procedure

The EUT is placed on a turn table which is 0.8 meter above ground. The turn table can rotate 360 degrees to determine the position of the maximum emission level. The EUT is set 3 meters away from the receiving antenna which is mounted on a antenna tower. The antenna can move up and down between 1 to 4 meters to find out the maximum emission level. Broadband antenna (calibrated by dipole antenna) are used as a receiving antenna. Both horizontal and vertical polarization of the antenna are set on test.

The bandwidth setting on the test receiver is 120 KHz.

The EUT is tested in Semi-Anechoic Chamber. and all the scanning waveform is put in **Appendix I.** 

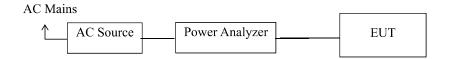
#### 6.7. Test Results

PASS.



## 7. HARMONIC CURRENT EMISSION TEST

## 7.1.Block Diagram of Test Setup



## 7.2. Test Standard and Limit

#### 7.2.1.Test Standard

EN61000-3-2:2014

#### 7.2.2.Limits

Table 12 Harmonic Current Test Limit (Class A)

Harmonic order (n)	Maximum permissible harmonic current (A)
	Odd harmonics
3	2.30
5	1.14
7	0.77
9	0.40
11	0.33
13	0.21
15≤n≤39	$0.15 \times 15/\mathbf{n}$
	Even harmonics
2	1.08
4	0.43
6	0.30
8≤n≤40	0.23×8/ <b>n</b>

## EST SERVICE OF TESTING BST Testing (Shenzhen) Co.,Ltd.

## 7.3.Test Procedure

The power cord of the EUT is connected to the output of the test system. Turn on the Power of the EUT and use the test system to test the harmonic current level.

## 7.4. Test Results

**PASS** 



## 8. VOLTAGE FLUCTUATIONS & FLICKER TEST

## 8.1.Block Diagram of Test Setup

Same as Section 7.1..

#### 8.2. Test Standard

EN61000-3-3:2013

## 8.3. Operating Condition of EUT

Same as Section 7.3.. The power cord of the EUT is connected to the output of the test system. Turn on the power of the EUT and use the test system to test.

#### Flicker Test Limit

Test items	Limits
Pst	1.0
dc	3.3%
dmax	4.0%
dt	Not exceed 3.3% for 500ms

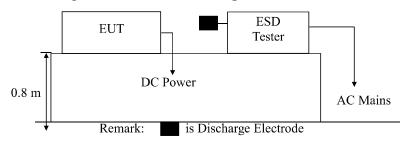
#### 8.4. Test Results

N/A



## 9. ELECTROSTATIC DISCHARGE TEST

#### 9.1.Block Diagram of ESD Test Setup



#### 9.2.Test Standard

EN 55035:2017(EN61000-4-2:2009) Severity Level 3 for Air Discharge at 8KV Severity Level 2 for Contact Discharge at 4KV

#### 9.3. Severity Levels and Performance Criterion

#### 9.3.1.Severity level

Level	Test Voltage Contact Discharge (KV)	Test Voltage Air Discharge (KV)
1.	2	2
2.	4	4
3.	6	8
4.	8	15
X.	Special	Special

#### 9.3.2.Performance criterion: B

## 9.4.EUT Configuration on Test

The configuration of EUT are listed in Section 3.2.

#### 9.5. Operating Condition of EUT

- 9.5.1. Setup the EUT as shown in Section 9.1.
- 9.5.2. Turn on the power of all equipments.
- 9.5.3.Let the EUT work in test mode (on) and test it.

#### 9.6. Test Procedure

#### 9.6.1.Air Discharge:

This test is done on a non-conductive surfaces. The round discharge tip of the discharge electrode shall be approached as fast as possible to touch the EUT.

After each discharge, the discharge electrode shall be removed from the EUT.

The generator is then re-triggered for a new single discharge and repeated 10 times for each pre-selected test point. This procedure shall be repeated until all the air discharge completed.

#### 9.6.2. Contact Discharge:

All the procedure shall be same as Section 9.6.1. except that the tip of the discharge electrode shall touch the EUT before the discharge switch is operated.

#### 9.6.3. Indirect discharge for horizontal coupling plane

At least 20 single discharges shall be applied to the horizontal coupling plane, at points on each side of the EUT. The discharge electrode positions vertically at a distance of 0.1m from the EUT and with the discharge electrode touching the coupling plane.

#### 9.6.4. Indirect discharge for vertical coupling plane

At least 20 single discharge shall be applied to the center of one vertical edge of the coupling plane. The coupling plane, of dimensions 0.5m X 0.5m, is placed parallel to, and positioned at a distance of 0.1m from the EUT. Discharges shall be applied to the coupling plane, with this plane in sufficient different positions that the four faces of the EUT are completely illuminated.

#### 9.7. Test Results

#### PASS.

Please refer to the following page.



## Electrostatic Discharge Test Results BST Testing (Shenzhen) Co.,Ltd.

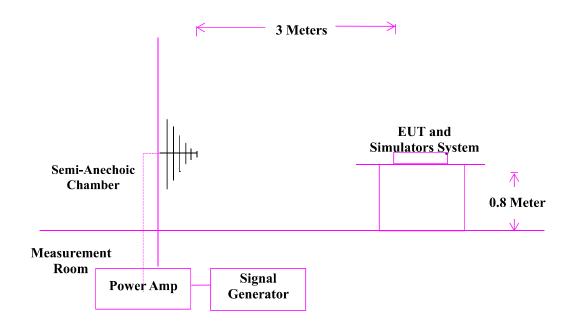
Applicant	SHEN ZHEN ROCKETEK ELECTRONI : CO., LTD	Test Date :	Jan.19.2021
EUT	: USB CARD READER	Temperature :	22 °C
M/N	. RT-SCR1	Humidity :	50%
		Test Mode :	on
Air Discharge	$\pm 8KV$ For each point positive	e 10 times and negative 10 ti.	mes discharge.
Contact Disci	harge: $\pm 4KV$		
	Location	<b>Kind</b> A-Air Dischar C-Contact Disch	
Slots		A	PASS
Metal Parts		C	PASS
НСР		С	PASS
VCP		C	PASS

Discharge should be considered on Contact and Air and Horizontal Coupling Plane (HCP) and Vertical Coupling Plane (VCP).



#### 10.RF FIELD STRENGTH SUSCEPTIBILITY TEST

## 10.1.R/S Test Setup



#### 10.2.Test Standard

EN 55035:2017 (EN 61000-4-3:2006 + A1:2008 + A2:2010) Severity Level 2 at 3V / m

## 10.3. Severity Levels and Performance Criterion

#### 10.3.1. Severity level

Level	Field Strength V/m
1.	1
2.	3
3.	10
X.	Special

10.3.2.Performance criterion: A

#### 10.4.EUT Configuration on Test

The configuration of EUT are listed in Section 3.2

#### 10.5. Operating Condition of EUT

Setup the EUT as shown in Section 10.1.. The operating condition of EUT are listed in section 3.3.

#### 10.6.Test Procedure

The EUT and its simulators are placed on a turn table which is 1 meter above the ground. The EUT is set 3 meters away from the transmitting antenna which is mounted on an antenna tower. Both horizontal and vertical polarization of the antenna are set on test. Each of the four sides of EUT must be faced this transmitting antenna and measured individually. In order to judge the EUT performance, a CCD camera is used to monitor the EUT. All the scanning conditions are as follows:

	Condition of Test	Remarks
1.	Fielded Strength	3 V/m (Severity Level 2)
2.	Radiated Signal	Modulated
3.	Scanning Frequency	80 - 1000 MHz, 1.4GHz-2.7GHz
4.	Sweeping time of radiated	0.0015 decade/s
5.	Dwell Time	1 Sec.

#### 10.7.Test Results

#### PASS.

Please refer to the following page.



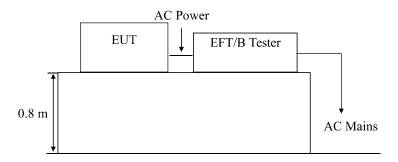
## RF Field Strength Susceptibility Test Results BST Testing (Shenzhen) Co.,Ltd.

Applicant	: SHEN ZI	HEN ROCKETEK ELECTRONICS	Test Date	:	Jan.19.2021
EUT	: USB CAR	RD READER	Temperat	ure :	22 °C
M/N	: RT-SCR1		Humidity	:	50%
			Test Mo	de :	on
Frequency Range :	80 MHz to	o 1000 MHz,1.4GHz-2.7GHz			
Modulation:	Ø	AM $\square$ Pulse $\square$ none	1 KHz 80	0%	
Criterion : A					
		Frequency Rang :			
		80-100	00MHZ, 1.4	GHz-2.7C	GHz
Steps		1%			1%
		Horizontal			Vertical
Front		Pass			Pass
Right		Pass			Pass
Rear		Pass			Pass
Left		Pass			Pass



#### 11.ELECTRICAL FAST TRANSIENT/BURST TEST

## 11.1.EFT Test Setup



#### 11.2.Test Standard

EN 55035:2017 (EN61000-4-4:2012) Severity Level 2 at 1KV

## 11.3. Severity Levels and Performance Criterion

#### 11.3.1.Severity level

	Open Circuit Output Test Voltage ±10%								
Level	On Power Supply Lines	On I/O (Input/Output) Signal							
		data and control lines							
1.	0.5 KV	0.25 KV							
2.	1 KV	0.5 KV							
3.	2 KV	1 KV							
4.	4 KV	2 KV							
X	Special	Special							

#### 11.3.2.Performance criterion: B

#### 11.4.EUT Configuration on Test

The configuration of EUT are listed in Section 3.2..

#### 11.5. Operating Condition of EUT

Setup the EUT as shown in Section 11.1.. The operating condition of EUT are listed in section 3.3.

#### 11.6.Test Procedure

The EUT is put on the table which is 1 meter high above the ground. This reference ground plane shall project beyond the EUT by at least 0.1m on all sides and the minimum distance between the EUT and all other conductive structure, except the ground plane beneath the EUT, shall be more than 0.5m.

#### 11.6.1. For input and output AC power ports:

The EUT is connected to the power mains by using a coupling device which couples the EFT interference signal to AC power lines. Both polarities of the test voltage should be applied during compliance test and the duration of the test is 2 mins.

#### 11.6.2. For signal lines and control lines ports:

It's unnecessary to test.

#### 11.6.3. For DC output line ports:

It's unnecessary to test.

#### 11.7.Test Results

**PASS** 



## Electrical Fast Transient/Burst Test Results

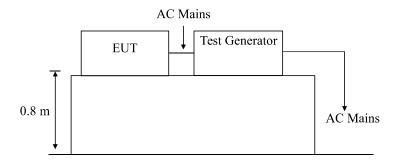
BST Testing (Shenzhen) Co.,Ltd.

Applicant				ROCKETEK S CO., LTD		Test Date	? :	Jan. 1	9.2021	
EUT	:	USB CA	ARD R	EADER		Tempera	ture :	22 °C		
M/N	:	RT-SCF	R <i>1</i>			Humidity	;	50%		
						Test Mod	le :	ON		
Inject Plac	e : AC	Mains								
Inject Line	Voltaş KV		nject me(s)	Inject Method	Results	Inject Line	Voltage KV	ject ne(s)	Inject Method	Results
L	±1		120	Direct						
N	±1		120	Direct						
L $N$	±1		120	Direct						



## 12.SURGE TEST

## 12.1.Surge Test Setup



#### 12.2.Test Standard

EN 55035:2017 (EN61000-4-5:2014) Severity Level 2 for Line to Neutral at 1.0KV

#### 12.3. Severity Levels and Performance Criterion

#### 12.3.1. Severity level

Severity Level	Open-Circuit Test Voltage
	KV
1	0.5
2	1.0
3	2.0
4 *	4.0
*	Special

Performance criterion: B

## 12.4.EUT Configuration on Test

The configuration of EUT are listed in Section 3.2.

## 12.5. Operating Condition of EUT

- 12.5.1. Setup the EUT as shown in Section 12.1..
- 12.5.2. Turn on the power of all equipments.
- 12.5.3.Let the EUT work in test mode (on) and test it.

#### 12.6.Test Procedure

- 1) Setup the EUT and test generator as shown on Section 12.1.
- 2) For line to line coupling mode, provide a 1.0KV 1.2/50us voltage surge (at open-circuit condition) and 8/20us current surge to EUT selected points.
- 3) At least 5 positive and 5 negative (polarity) tests with a maximum 1/min repetition rate are conducted during test.
- 4) Different phase angles are done individually.
- 5) Record the EUT operating situation during compliance test and decide the EUT immunity criterion for above each test.

#### 12.7.Test Results

**PASS** 

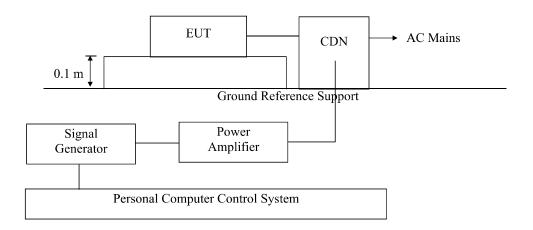


## Surge Immunity Test Results BST Testing (Shenzhen) Co.,Ltd.

Applicant :	: SHI ELE	EN Z ECTRONICS	HEN CO., LTD	ROCKETEK	Test Date	:	Jan.19.2021
EUT :		3 CARD REA			Temperature	:	22 °C
<i>M/N</i> :	RT-	SCR1			Humidity	:	50%
					Test Mode	:	ON
Location		Polarity	Phase Angle	No of Pulse	Pulse Voltage (	(KV)	Result
L- $N$		+	0	5	1.0		
		+	90	5	1.0		
		+	180	5	1.0		
		+	270	5	1.0		
		-	0	5	1.0		
		-	90	5	1.0		
		-	180	5	1.0		
		-	270	5	1.0		

#### 13.INJECTED CURRENTS SUSCEPTIBILITY TEST

## 13.1.Block Diagram of Test AC Mains Setup



#### 13.2.Test Standard

EN 55035:2017 (EN61000-4-6:2014) Severity Level 2 at 3 V (rms), 0.15MHz ~ 80MHz

#### 13.3. Severity Levels and Performance Criterion

#### 13.3.1. Severity level

Level	Field Strength V/m
1.	1
2.	3
3.	10
X	Special

#### 13.3.2.Performance criterion: A

#### 13.4.EUT Configuration on Test

The configuration of EUT are listed in Section 3.2

#### 13.5. Operating Condition of EUT

Setup the EUT as shown in Section 13.1.. The operating condition of EUT are listed in section 3.3

#### 13.6.Test Procedure

- 1) Set up the EUT, CDN and test generators as shown on Section 13.1.
- 2) Let the EUT work in test mode and test it.
- 3) The EUT are placed on an insulating support 0.8m high above a ground reference plane. CDN (coupling and decoupling device) is placed on the ground plane about 0.3m from EUT. Cables between CDN and EUT are as short as possible, and their height above the ground reference plane shall be between 30 and 50 mm (where possible).
- 4) The disturbance signal described below is injected to EUT through CDN.
- 5) The EUT operates within its operational mode(s) under intended climatic conditions after power on.
- 6) The frequency range is swept from 150KHz to 80MHz using 3V signal level, and with the disturbance signal 80% amplitude modulated with a 1KHz sine wave.
- 7) The rate of sweep shall not exceed 1.5\*10<sup>-3</sup>decades/s. Where the frequency is swept incrementally, the step size shall not exceed 1% of the start and thereafter 1% of the preceding frequency value.
- 8) Recording the EUT operating situation during compliance testing and decide the EUT immunity criterion.

#### 13.7.Test Results

**PASS** 

## Injected Currents Susceptibility Test Results BST Testing (Shenzhen) Co.,Ltd.

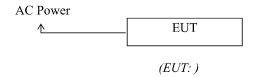
Applicant	: SH	EN	ZHEN	ROCKETEK	Test Date	:	Jan.19.2	2021
	ELE	CTRONIC	CS CO., LTD					
EUT	: USB	CARD R	EADER		Temperature	e :	22 °C	
M/N	: <u>RT-S</u>	CR1			Humidity	:	50%	
					Test Mode	:	ON	
Frequency F (MHz)		Inje	ected Position	Str	rength	Crit	erion	Result
0.15 ~ 2	20		AC Line		(rms), odulated	A		
20 ~ 80	)		AC Line		(rms), odulated	A		



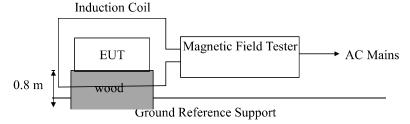
#### 14.MAGNETIC FIELD IMMUNITY TEST

#### 14.1.Block Diagram of Test Setup

#### 14.1.1.Block Diagram of the EUT



#### 14.1.2.Block Diagram of Test Setup



#### 14.2.Test Standard

EN 55035:2017 (EN61000-4-8: 2010) Severity Level 1 at 1A/m

#### 14.3. Severity Levels and Performance Criterion

#### 14.3.1. Severity level

Level	Magnetic Field Strength A/m
1.	1
2.	3
3.	10
4.	30
5.	100
X.	Special

#### 14.3.2.Performance criterion: A

## 14.4.EUT Configuration on Test

The configuration of EUT are listed in Section 3.2.

#### 14.5. Operating Condition of EUT

- 14.5.1. Setup the EUT as shown in Section 14.1
- 14.5.2. Turn on the power of all equipments.
- 14.5.3.Let the EUT work in test mode (ON) and test it.

#### 14.6.Test Procedure

The EUT shall be subjected to the test magnetic field by using the induction coil of standard dimensions (1m\*1m) and shown in Section 14.1. The induction coil shall then be rotated by 90° in order to expose the EUT to the test field with different orientations.

#### 14.7.Test Results

#### PASS.

Please refer to the following page.

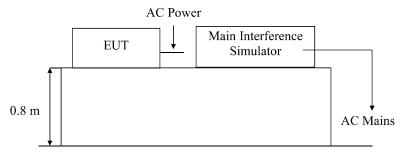
## Magnetic Field Immunity Test Results BST Testing (Shenzhen) Co., Ltd.

Applicant: SHEN	ZHEN ROCKETEK ELI	ECTRONICS CC	)., Test	Date : Jan.19.2021	
EUT: USB CARD	READER		Tem	perature : 22 $^{\circ}$ C	
M/N: RT-SCR1			Hum	nidity : 60 %	
Test Mode: ON					
Test Level	Testing Duration	Coil Orienta	ition	Criterion	Result
1A/M	5 mins	Horizonte	al	A	PASS
1A/M	5 mins	Vertical		A	PASS
Remark:				ιipment <b>:</b> ic Field Tester MAG100	9.1



#### 15. VOLTAGE DIPS AND INTERRUPTIONS TEST

## 15.1. Voltage Dips and Interruptions Test Setup



Remark: Combination wave generator and decoupling network are included in test generator.

#### 15.2.Test Standard

EN 55035:2017 (EN61000-4-11:2004)

#### 15.3. Severity Levels and Performance Criterion

#### 15.3.1. Severity level

Test Level %UT	Voltage dip and short interruptions %UT	Duration (in period)
0	100	250р
40	60	5p
70	30	0.5p

#### 15.3.2.Performance criterion: C & B

#### 15.4.EUT Configuration on Test

The configuration of EUT are listed in Section 3.2.

## 15.5.Operating Condition of EUT

- 15.5.1. Setup the EUT as shown in Section 15.1.
- 15.5.2. Turn on the power of all equipments.
- 15.5.3.Let the EUT work in test mode (On) and test it.

#### 15.6.Test Procedure

- 1) Set up the EUT and test generator as shown on Section 15.1.
- 2) The interruptions is introduced at selected phase angles with specified duration.
- 3) Record any degradation of performance.

## 15.7.Test Result

**PASS** 

## Voltage Dips And Interruptions Test Results BST Testing (Shenzhen) Co.,Ltd.

Applicant :	SHEN ZHEN ROCK	KETEK ELECTRONI	CS Test Date	÷	Jan	.19.2021
EUT :	USB CARD READI	ER	Temperature	÷	22 %	C
<i>M/N</i> :	RT-SCR1		Humidity	÷	50%	%
			Test Mode	:	ON	
Test Level $\% U_T$	Voltage Dips & Short Interruptions $\% U_T$	Duration (in period)	Phase Angle	Criter	ion	Result
0	100	250P	0°~360°	С		
40	60	5P	0°~360°	C		
70	30	0.5P	0° ~360°	В		

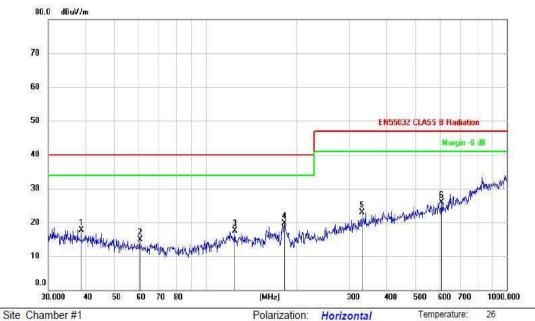


## **APPENDIX I**

Humidity:

55 %

#### BST Testing (Shenzhen) Co.,Ltd.



Limit: EN55032 CLASS B Radiation

Power:

Distance:

EUT: M/N:

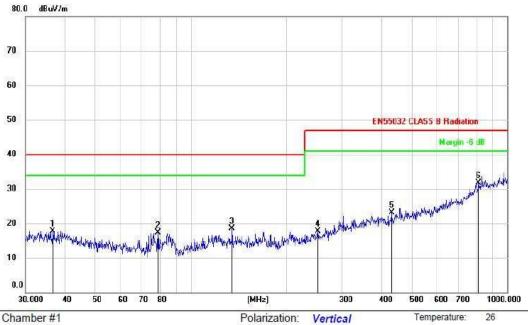
Mode: Note:

No. Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		Antenna Height	Table Degree	
	MHz	dBuV	dBuV/m	dBuV/m	dBuV/m	dB	Detector	cm	degree	Comment
1	38.6160	13.28	4.45	17.73	40.00	-22.27	QP			
2	60.4919	13.44	1.44	14.88	40.00	-25.12	QP			
3	125.0066	13.67	3.91	17.58	40.00	-22.42	QP			
4 *	182.5592	17.52	2.21	19.73	40.00	-20.27	QP			
5	330.1949	14.92	7.95	22.87	47.00	-24.13	QP			
6	607.7867	14.49	11.50	25.99	47.00	-21.01	QP			

Humidity:

55 %

#### BST Testing (Shenzhen) Co.,Ltd.



Power:

Distance:

Site Chamber #1

Limit: EN55032 CLASS B Radiation

EUT:

M/N:

Mode: Note:

No. Mk.	. Freq.	Reading Level dBuV	Correct Factor	Measure- ment dBuV/m	Limit dBuV/m	Over	Detector	Antenna Height	Table Degree degree	Comment
2	78.6888	16.11	1.23	17.34	40.00	-22.66	QP			
3	135.0319	15.02	3.42	18.44	40.00	-21.56	QP			
4	252.0627	13.05	4.75	17.80	47.00	-29.20	QP			
5	431.0316	13.49	9.64	23.13	47.00	-23.87	QP			
6 *	813.1115	14.24	17.54	31.78	47.00	-15.22	QP			



## **APPENDIX II**



#### **Photo 1 General Appearance of the EUT**



**Photo 2 General Appearance of the EUT** 





#### Photo 3 Test scene

